Selective peak inference: Unbiased estimation of the effect size at local maxima

Samuel Davenport and Thomas E. Nichols

University of Oxford

May 18, 2021

Double Dipping

2 Methods

3 Big Data Validation

Double Dipping

Examples

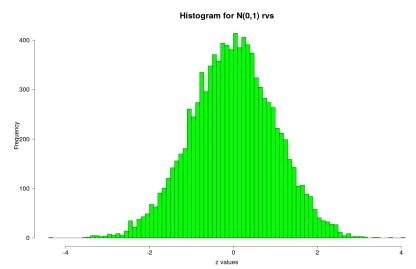
• Dice Example: Imagine you roll 10 fair dice and at random some of them show a 6. If you rolled them again would you expect them still to be 6?



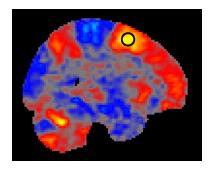
Figure 1: Some Dice

Mean 0 example

Suppose for now that we have 10000 independent N(0,1) random variables. Then the largest are biased estimates for the true mean.



The Winner's Curse in fMRI



- Choose significant voxels based on some statistic and its maxima.
- Report uncorrected values at peaks











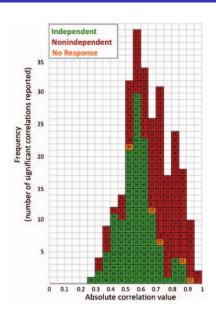
- Use half for significance and half for estimation of the effect size.
- Solves the bias problem as have independence across subjects.





- Use half for significance and half for estimation of the effect size.
- Solves the bias problem as have independence across subjects.
- Issues: Less data to estimate so higher variance.

Vul et al 2009



Methods

General Definitions

- \mathcal{V} : set of voxel locations
- Define an **image** to be a map $Z: \mathcal{V} \to \mathbb{R}$.
- Define a local maxima or peak of Z to be a voxel $v \in \mathcal{V}$ such that the value that Z takes at that location is larger than the value Z takes at neighbouring voxels

One-Sample Model

Suppose that we have N subjects and for each n = 1, ..., N a corresponding random image Y_n on \mathcal{V} such that for every voxel $v \in \mathcal{V}$,

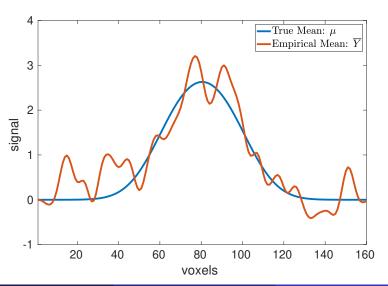
$$Y_n(v) = \mu(v) + \epsilon_n(v).$$

- $\mu(v)$ is the common mean intensity
- $\epsilon_1, \ldots, \epsilon_n$ are iid mean zero random images from some unknown multivariate distribution on \mathcal{V}
- Let $\hat{\mu} = \frac{1}{N} \sum_{n=1}^{N} Y_n$
- let \hat{v}_k be the location of the kth largest local maximum of $\hat{\mu}$

We want to know $\mu(\hat{v}_k)$, but we have $\hat{\mu}(\hat{v}_k)$.

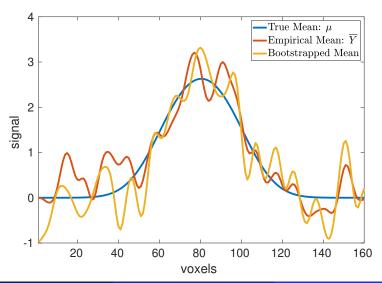
1D Example

20 subjects,
$$Y_n(t) = \mu(t) + \epsilon_n(t), \ \hat{\mu} = \overline{Y} = \frac{1}{20} \sum_{n=1}^{20} Y_n$$

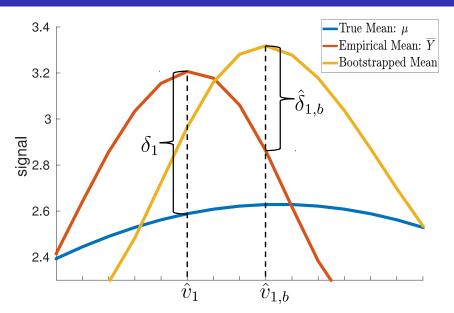


1D Example - Bootstrap Method

20 subjects,
$$Y_n(t) = \mu(t) + \epsilon_n(t)$$
, $\hat{\mu} = \overline{Y} = \frac{1}{20} \sum_{n=1}^{20} Y_n$



1D Example - Bootstrap Method



Algorithm 1 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and screening threshold u.
- 2: Let $\hat{\mu} = \frac{1}{N} \sum_{n=1}^{N} Y_n$ and let K be the number of peaks of $\hat{\mu}$ above u, and for k = 1, ..., K, let \hat{v}_k be the location of the kth largest maxima of $\hat{\mu}$.

Algorithm 2 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and screening threshold u.
- 2: Let $\hat{\mu} = \frac{1}{N} \sum_{n=1}^{N} Y_n$ and let K be the number of peaks of $\hat{\mu}$ above u, and for $k = 1, \ldots, K$, let \hat{v}_k be the location of the kth largest maxima of $\hat{\mu}$.
- 3: **for** b = 1, ..., B **do**
- 4: Sample $Y_{1,b}^*, \ldots, Y_{N,b}^*$ independently with replacement from Y_1, \ldots, Y_N .
- 5: Let $\hat{\mu}_b = \frac{1}{N} \sum_{n=1}^N Y_{N,b}^*$ and for k = 1, ..., K, let $\hat{v}_{k,b}$ be the location of the kth largest local maxima of $\hat{\mu}_b$.
- 6: For k = 1, ..., K, let $\hat{\delta}_{k,b} = \hat{\mu}_b(\hat{v}_{k,b}) \hat{\mu}(\hat{v}_{k,b})$ be an estimate of the bias at the kth largest local maxima.
- 7: end for

Algorithm 3 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and screening threshold u.
- 2: Let $\hat{\mu} = \frac{1}{N} \sum_{n=1}^{N} Y_n$ and let K be the number of peaks of $\hat{\mu}$ above u, and for $k = 1, \ldots, K$, let \hat{v}_k be the location of the kth largest maxima of $\hat{\mu}$.
- 3: **for** b = 1, ..., B **do**
- 4: Sample $Y_{1,b}^*, \dots, Y_{N,b}^*$ independently with replacement from Y_1, \dots, Y_N .
- 5: Let $\hat{\mu}_b = \frac{1}{N} \sum_{n=1}^N Y_{N,b}^*$ and for k = 1, ..., K, let $\hat{v}_{k,b}$ be the location of the kth largest local maxima of $\hat{\mu}_b$.
- 6: For k = 1, ..., K, let $\hat{\delta}_{k,b} = \hat{\mu}_b(\hat{v}_{k,b}) \hat{\mu}(\hat{v}_{k,b})$ be an estimate of the bias at the kth largest local maxima.
- 7: end for
- 8: For k = 1, ..., K, let $\hat{\delta}_k = \frac{1}{B} \sum_{b=1}^{B} \hat{\delta}_{k,b}$.
- 9: **return** $(\hat{\mu}(\hat{v}_1) \hat{\delta}_1, \dots, \hat{\mu}(\hat{v}_K) \hat{\delta}_K)$.

One-Sample t-statistics/Cohen's d

In neuroimaging we are interested in testing

$$H_0(v): \mu(v) = 0 \text{ versus } H_1(v): \mu(v) \neq 0$$

using the one-sample t-statistic:

$$t = \frac{\hat{\mu}\sqrt{N}}{\hat{\sigma}}$$

where

$$\hat{\mu} = \frac{1}{N} \sum_{n=1}^{N} Y_n, \quad \hat{\sigma}^2 = \frac{1}{N-1} \sum_{n=1}^{N} (Y_n - \hat{\mu})^2.$$

Effect size is measured via

$$\hat{d}(v) = \frac{\hat{\mu}}{\hat{\sigma}}$$

but this is a biased estimator for the population Cohen's d:

$$d(v) = \frac{\mu}{\sigma}$$
.

Unbiased Cohen's d Estimation

This t-statistic $\hat{\mu}\sqrt{N}/\hat{\sigma}$ has a non-central t-distribution with non-centrality parameter $\mu\sqrt{N}/\sigma$ and N-1 degrees of freedom. Thus

$$\mathbb{E}\left[\frac{\hat{\mu}\sqrt{N}}{\hat{\sigma}}\right] = \frac{\mu}{\sigma}\sqrt{\frac{N-1}{2}}\frac{\Gamma((N-2)/2)}{\Gamma((N-1)/2)} = C_N \frac{\mu\sqrt{N}}{\sigma}$$

for N > 2, where Γ is the gamma function and C_N is a bias correction factor (?, ?). So we can use

$$\frac{\hat{\mu}}{\hat{\sigma}C_N}$$

as an unbiased of the population Cohen's d.

Algorithm 4 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and threshold u.
- 2: Let K be the number of peaks of t above u and for k = 1, ..., K, let \hat{v}_k be the location of the kth largest maxima of $\hat{d} = \hat{\mu}/\hat{\sigma}$.

Algorithm 5 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and threshold u.
- 2: Let K be the number of peaks of t above u and for $k = 1, \ldots, K$, let \hat{v}_k be the location of the kth largest maxima of $\hat{d} = \hat{\mu}/\hat{\sigma}$.
- 3: **for** b = 1, ..., B **do**
- 4: Sample $Y_{1,b}^*, \ldots, Y_{N,b}^*$ independently with replacement from Y_1, \ldots, Y_N .
- 5: Let $\hat{\mu}_b = \frac{1}{N} \sum_{n=1}^N Y_{n,b}^*$ and let $\hat{\sigma}_b^2(v) = \frac{1}{N-1} \sum_{n=1}^N (Y_{n,b}^*(v) \hat{\mu}_b(v))^2$ for each $v \in \mathcal{V}$.

Algorithm 6 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and threshold u.
- 2: Let K be the number of peaks of t above u and for $k = 1, \ldots, K$, let \hat{v}_k be the location of the kth largest maxima of $\hat{d} = \hat{\mu}/\hat{\sigma}$.
- 3: **for** b = 1, ..., B **do**
- 4: Sample $Y_{1,b}^*, \ldots, Y_{N,b}^*$ independently with replacement from Y_1, \ldots, Y_N .
- 5: Let $\hat{\mu}_b = \frac{1}{N} \sum_{n=1}^{N} Y_{n,b}^*$ and let $\hat{\sigma}_b^2(v) = \frac{1}{N-1} \sum_{n=1}^{N} (Y_{n,b}^*(v) \hat{\mu}_b(v))^2$ for each $v \in \mathcal{V}$.
- 6: For k = 1, ..., K, let $\hat{v}_{k,b}$ be the location of the kth largest local maxima of $\hat{d}_b = \hat{\mu}_b/\hat{\sigma}_b$.
- 7: Let $\hat{\delta}_{k,b} = (\hat{d}_b(\hat{v}_{k,b}) \hat{d}(\hat{v}_{k,b}))/C_N$ be an estimate of the bias.
- 8: end for

Algorithm 7 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and threshold u.
- 2: Let K be the number of peaks of t above u and for $k = 1, \ldots, K$, let \hat{v}_k be the location of the kth largest maxima of $\hat{d} = \hat{\mu}/\hat{\sigma}$.
- 3: **for** b = 1, ..., B **do**
- 4: Sample $Y_{1,b}^*, \ldots, Y_{N,b}^*$ independently with replacement from Y_1, \ldots, Y_N .
- 5: Let $\hat{\mu}_b = \frac{1}{N} \sum_{n=1}^N Y_{n,b}^*$ and let $\hat{\sigma}_b^2(v) = \frac{1}{N-1} \sum_{n=1}^N (Y_{n,b}^*(v) \hat{\mu}_b(v))^2$ for each $v \in \mathcal{V}$.
- 6: For k = 1, ..., K, let $\hat{v}_{k,b}$ be the location of the kth largest local maxima of $\hat{d}_b = \hat{\mu}_b/\hat{\sigma}_b$.
- 7: Let $\hat{\delta}_{k,b} = (\hat{d}_b(\hat{v}_{k,b}) \hat{d}(\hat{v}_{k,b}))/C_N$ be an estimate of the bias.
- 8: end for
- 9: For k = 1, ..., K, let $\hat{\delta}_k = \frac{1}{B} \sum_{b=1}^{B} \hat{\delta}_{k,b}$
- 10: **return** $(\hat{d}(\hat{v}_1)/C_N \hat{\delta}_1, \dots, \hat{d}(\hat{v}_K)/C_N \hat{\delta}_K)$.

Estimation of the mean

To infer on μ instead of μ/σ can just use

$$\hat{\delta}_{k,b} = \hat{\mu}_b(\hat{v}_{k,b}) - \hat{\mu}(\hat{v}_{k,b})$$

Circular Inference and Data-Splitting

- Circular inference estimates are: $\hat{d}(\hat{v}_1)/C_N, \dots, \hat{d}(\hat{v}_K)/C_N$.
- For data-splitting, we first divide the images into two groups: $Y_1, \ldots, Y_{N/2}$ and $Y_{N/2+1}, \ldots, Y_N$. Then find the peaks using the first half of the subjects and estimate the values at those peaks using the second half of the subjects.

GLM

Let Y be an N-dimensional random image such that for each $v \in \mathcal{V}$

$$Y(v) = X\beta(v) + \epsilon(v)$$

- $N \times p$ design matrix X
- parameter vector $\beta(v) \in \mathbb{R}^p$
- $\epsilon(v) = (\epsilon_1(v), \dots, \epsilon_N(v))^T$ is the random image of the noise

GLM

Let Y be an N-dimensional random image such that for each $v \in \mathcal{V}$

$$Y(v) = X\beta(v) + \epsilon(v)$$

- $N \times p$ design matrix X
- parameter vector $\beta(v) \in \mathbb{R}^p$
- $\epsilon(v) = (\epsilon_1(v), \dots, \epsilon_N(v))^T$ is the random image of the noise

We are interested in testing

$$H_0(v): C\beta(v) = 0$$
 versus $H_1(v): C\beta(v) \neq 0$

for some contrast matrix $C \in \mathbb{R}^{m \times p}$. We can test this at each voxel with the usual F-test,

$$F(v) = \frac{(C\hat{\beta}(v))^T (C(X^T X)^{-1} C^T)^{-1} (C\hat{\beta}(v))/m}{\hat{\sigma}(v)^2}$$
(1)

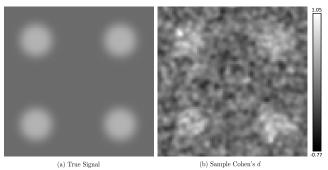
where $\hat{\beta}(v) = (X^T X)^{-1} X^T Y$ and $\hat{\sigma}^2(v)$ is the error variance. Under the alternative has a non-central F-distribution.

Algorithm 8 Non-Parametric Bootstrap Bias Calculation

- 1: **Input**: Images Y_1, \ldots, Y_N , the number of bootstrap samples B and threshold u.
- 2: Let $\hat{\beta} = \hat{\beta}(X,Y) = (X^TX)^{-1}X^TY$ and let $\hat{\epsilon} = Y X\hat{\beta}$ be the residuals.
- 3: For each $n=1,\ldots,N$, let $r_n=\hat{\epsilon}_n/\sqrt{1-p_n}$ be the modified residuals, where $p_n=(X(X^TX)^{-1}X^T)_{nn}$. Let $\overline{r}=\frac{1}{N}\sum_{n=1}^N r_i$ be their mean.
- 4: **for** b = 1, ..., B **do**
- 5: Sample $\epsilon_{1,b}^*, \dots, \epsilon_{N,b}^*$ independently with replacement from $r_1 \overline{r}, \dots, r_N \overline{r}$ and let $\epsilon_b^* = (\epsilon_{1,b}^*, \dots, \epsilon_{N,b}^*)^T$ and set $Y_b^* = X\hat{\beta} + \epsilon^*$.
- 6: Let F_b^* be the bootstrapped F-statistic image computed using Y_b^* . Let R_b^2 be the bootstrapped partial R^2 image and set $\hat{\delta}_{k,b} = R_b^2(\hat{v}_{k,b}) R^2(\hat{v}_{k,b})$ to be the estimate of the bias.
- 7: end for
- 8: For k = 1, ..., K, let $\hat{\delta}_k = \frac{1}{B} \sum_{b=1}^{B} \hat{\delta}_{k,b}$.
- 9: **return** $(R^2(\hat{v}_1) \hat{\delta}_1, \dots, R^2(\hat{v}_K) \hat{\delta}_K)$.

Simulations - Cohen's d

All simulations generated using code from the RFTtoolbox https://github.com/BrainStatsSam/RFTtoolbox (avoiding edge problems)



- Panel (a) illustrates a slice through the true signal (actually 9 peaks only 4 shown).
- Panel (b) illustrates the same slice through the one sample Cohen's d for 50 subjects. Noise: Gaussian random field with FWHM 6.

Bias, RMSE and standard deviation

Traditionally, one estimates a common θ with estimators $\hat{\theta}_1, ..., \hat{\theta}_K$ however we have estimators $\hat{\theta}_1, ..., \hat{\theta}_K$ of parameters $\theta_1, ..., \theta_K$ where K is the number of significant peaks that are found over all realizations. As such we instead define

$$\tilde{\theta}_k = \hat{\theta}_k - \theta_k$$

and use the fact that the noise-free value of $\tilde{\theta}_k$ is 0 for each k.

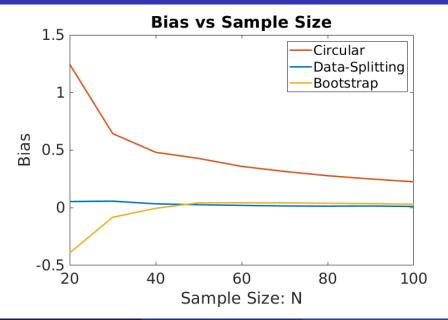
MSE =
$$\frac{1}{K} \sum_{k=1}^{K} (\tilde{\theta}_k - 0)^2$$

= $\frac{1}{K} \sum_{k=1}^{K} (\tilde{\theta}_k - \frac{1}{K} \sum_{k=1}^{K} \tilde{\theta}_k)^2 + \left(\frac{1}{K} \sum_{k=1}^{K} \tilde{\theta}_k\right)^2$

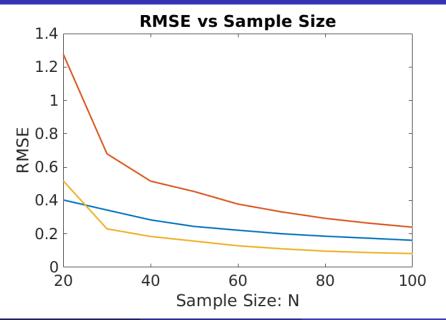
Simulation Evaluation and Thresholding

- We evaluate our methods for $N = \{20, 30, \dots, 100\}$.
- For each N we generate 1,000 realizations and compare the performance of the three methods across realizations.

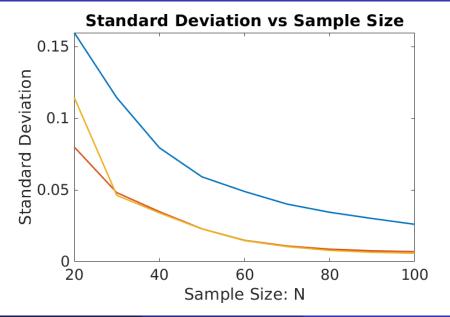
Results - One Sample Cohen's d simulations Bias



Results - One Sample Cohen's d simulations RMSE



Results - One Sample Cohen's d simulations STD





Data and Testing

- 8940 total subjects from the UK biobank. We have task fMRI and VBM data from all subjects
- We test the one-sample methods using the task fMRI data and the GLM methods using the VBM data (as the R^2 effect sizes are very small for the task fMRI data sets)
- For the task-fMRI data we estimate Cohen's d or μ .
- For the VBM data we regress against age, sex and an intercept and compute the partial R^2 for age.
- Set aside 4000 subjects to compute a ground truth and divide the rest into $G_N = 4940/N$ groups of size N = 20, 50, 100.
- Actually for the VBM data we take N=50,100,150 as the effect size is lower

We recommend this type of testing framework for all statistical methods.

Thresholding using Voxelwise RFT

- We threshold using voxelwise RFT to control the FWER.
- I.e. if \mathcal{V}_0 is the set of null voxels (i.e. where the mean is 0) and T is the test-statistic, then if we threshold at a level u, then

$$FWER = \mathbb{P}\left(\max_{v \in \mathcal{V}_0} T(v) > u\right)$$

We can upper bound this by the probability that a mean-zero test-statistic field exceeds a level u and choose u to ensure that FWER ≤ 0.05 .

- Parametric approximations to this probability can be computed using the expected Euler characteristic heuristic.
- Alternatively can use non-parametric methods (such as permutation.)

Cohen's d ground truth

Computing the ground truth is difficult due to memory constraints. So you have load images sequentially. Let \mathcal{D} be the set of all possible voxels. Typically \mathcal{D} is a $91 \times 109 \times 91$ grid. Define

$$M_n(v) = \begin{cases} 1 & \text{if subject } n \text{ has data at } v \\ 0 & \text{otherwise} \end{cases}$$

Cohen's d ground truth

Computing the ground truth is difficult due to memory constraints. So you have load images sequentially. Let \mathcal{D} be the set of all possible voxels. Typically \mathcal{D} is a $91\times 109\times 91$ grid. Define

$$M_n(v) = \begin{cases} 1 & \text{if subject } n \text{ has data at } v \\ 0 & \text{otherwise} \end{cases}$$

Take $S \subset \{1, \dots, 8940\}$ of size 4000 and let

$$\mu(v) = \frac{\sum_{n \in \mathcal{S}} Y_n(v) M_n(v)}{\sum_{n \in \mathcal{S}} M_n(v)} \times \mathbb{1}(M_n(v) = 1 \text{ for at least } 100 \ n \in \mathcal{S})$$

$$\sigma^2(v) = \frac{\sum_{n \in \mathcal{S}} (Y_n - \mu(v))^2 M_n(v)}{\sum_{n \in \mathcal{S}} M_n(v) - 1} \times \mathbb{1}(M_n(v) = 1 \text{ for at least } 100 \ n \in \mathcal{S}),$$

Cohen's d ground truth

$$\mu(v) = \frac{\sum_{n \in \mathcal{S}} Y_n(v) M_n(v)}{\sum_{n \in \mathcal{S}} M_n(v)} \times \mathbb{1}(M_n(v) = 1 \text{ for at least } 100 \ n \in \mathcal{S})$$

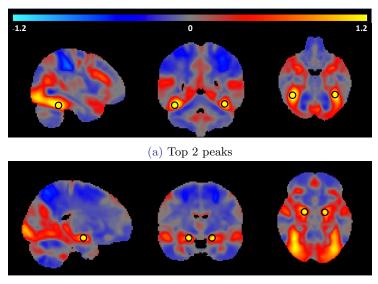
$$\sigma^2(v) = \frac{\sum_{n \in \mathcal{S}} (Y_n - \mu(v))^2 M_n(v)}{\sum_{n \in \mathcal{S}} M_n(v) - 1} \times \mathbb{1}(M_n(v) = 1 \text{ for at least } 100 \ n \in \mathcal{S}),$$

and the ground truth Cohen's d estimate as

$$d(v) = \frac{\mu(v)}{\sigma(v)}.$$

Finally each of these are additionally masked with the 2mm MNI brain mask.

Cohen's d Ground Truth Slices



(b) 3rd and 4th Highest Peaks

Illustrating the Winner's Curse

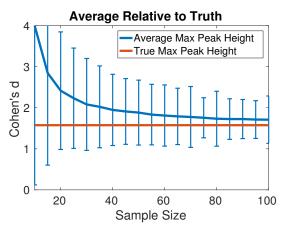


Figure 4: Comparing the maximum values at small sample Cohen's d (over the G_N groups) to the max ground truth value.

GLM ground truth

For now assume that no data is missing and that we have

- $N_{\text{all}} = 4000 \text{ subjects}$
- an $N_{\rm all} \times p$ design matrix $X = (x_1, \dots, x_{N_{\rm all}})^T$
- V is the number of voxels in each subject image Y_n
- Y be the $N_{\rm all} \times V$ matrix of all the subject images

GLM ground truth

For now assume that no data is missing and that we have

- $N_{\rm all} = 4000 \text{ subjects}$
- an $N_{\text{all}} \times p$ design matrix $X = (x_1, \dots, x_{N_{\text{all}}})^T$
- V is the number of voxels in each subject image Y_n
- Y be the $N_{\rm all} \times V$ matrix of all the subject images

For $Y = X\beta + \epsilon$, we want to compute

$$\hat{\beta} = (X^T X)^{-1} X^T Y,$$

at each voxel. For each $v \in \mathcal{V}$,

$$X^{T}Y(v) = (x_1, \dots, x_{N_{\text{all}}}) \begin{pmatrix} Y_1(v) \\ \vdots \\ Y_{N_{\text{all}}}(v) \end{pmatrix} = \sum_{n=1}^{N_{\text{all}}} Y_n(v) x_n,$$

$$\hat{\sigma}^2 = (N_{\text{all}} - p)^{-1} \sum_{n=1}^{N_{all}} (Y_n - x_n^T \hat{\beta})^2.$$

and this allows F and R^2 to be calculated

GLM ground truth

For each $v \in \mathcal{V}$,

$$X^{T}Y(v) = (x_{1}, \dots, x_{N_{\text{all}}}) \begin{pmatrix} Y_{1}(v) \\ \vdots \\ Y_{N_{\text{all}}}(v) \end{pmatrix} = \sum_{n=1}^{N_{all}} Y_{n}(v)x_{n},$$

Can compute $\hat{\beta} = (X^T X)^{-1} X^T Y$ from this and estimate

$$\hat{\sigma}^2 = (N_{\text{all}} - p)^{-1} \sum_{n=1}^{N_{all}} (Y_n - x_n^T \hat{\beta})^2.$$

and this allows F and R^2 to be calculated.

GLM ground truth with missingness

Let $C(v) := \{n : M_n(v) = 1\}$. Then for each voxel v we need to compute the complete case estimate

$$\hat{\beta}(v) = (X_{C(v)}^T X_{C(v)})^{-1} X_{C(v)}^T Y_{C(v)}.$$

The first and second parts of this expression can be computed as

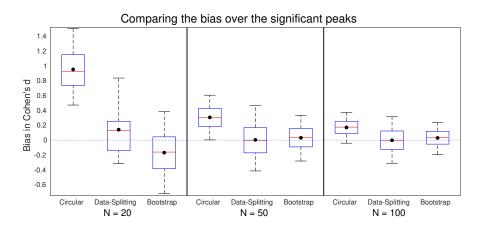
$$(X_{C(v)}^T X_{C(v)})^{-1} = \left(\sum_{n=1}^{N_{\text{all}}} M_n(v) x_n x_n^T\right)^{-1}$$

and

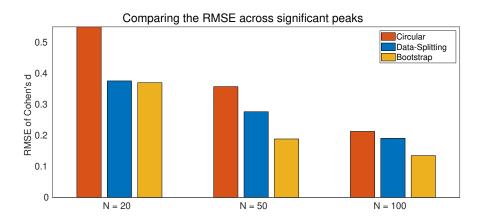
$$X_{C(v)}^{T} Y_{C(v)} = \sum_{n=1}^{N_{\text{all}}} M_n(v) Y_n(v) x_n$$

 $\hat{\sigma}^2$, F and R^2 can similarly be computed.

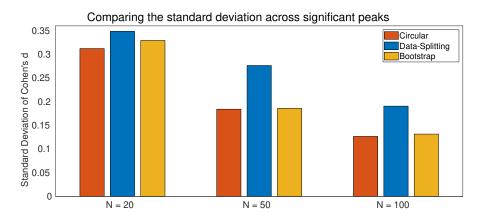
One Sample Cohen's d - Bias



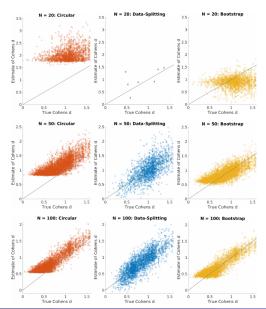
One Sample Cohen's d - RMSE



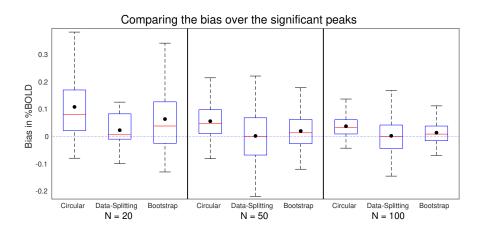
One Sample Cohen's d - Standard Deviation



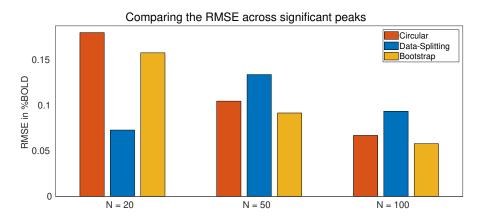
One Sample Cohen's d - Estimates vs Ground truth



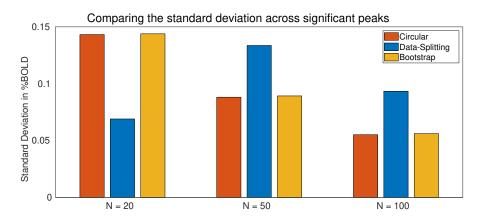
Mean estimation - Bias



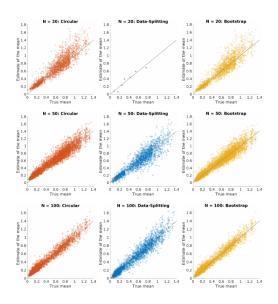
Mean estimation - RMSE



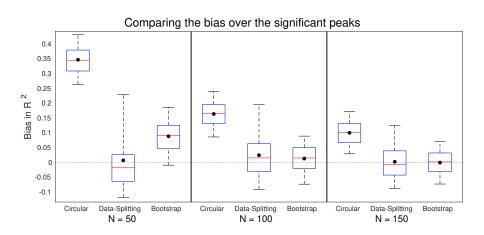
Mean estimation - Standard Deviation



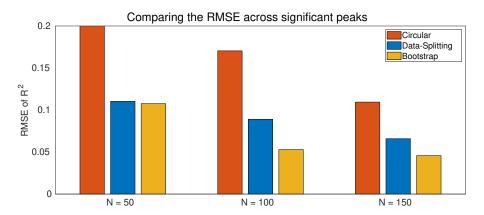
Mean estimation - Estimates versus Ground truth



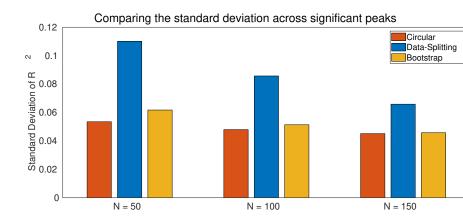
R^2 - Bias



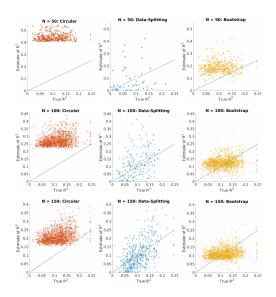
R^2 - RMSE



R^2 - Standard Deviation



R^2 - Estimates versus Ground truth



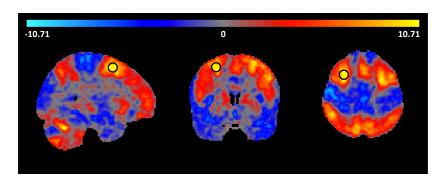
One-Sample t-statistic power

Given a potential future sample size N' and an estimate of Csohen's $d:\hat{d}$, the power is:

$$\mathbb{P}(T_{N'-1,\hat{d}} > t_{1-\alpha,N'-1})$$

where $t_{1-\alpha,N'-1}$ is chosen such that $\mathbb{P}(T_{N'-1,0} > t_{1-\alpha,N'-1}) = \alpha$ and $T_{N'-1,\lambda}$ has a non-central T distribution with N'-1 degrees of freedom.

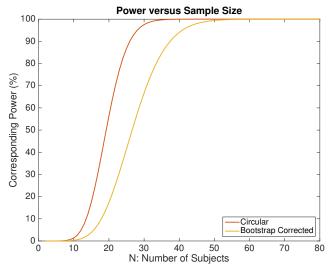
Working Memory Example



- One-sample t-statistic for 80 subjects from the HCP.
- Activation in the Medial Frontal Gyrus.
- \bullet At the maximum the observed (circular) Cohen's d is 1.519, while the bootstrap-corrected value is 1.161
- The observed %BOLD change there is %0.450 and corrected estimate is %0.433.

Power graph

At the maximum the observed (circular) Cohen's d is 1.519, while the bootstrap-corrected value is 1.161. So we can generate a power graph:



Conclusion and Future Work

- We provide a method for dealing with the winner's curse which outperforms existing methods in terms of RMSE.
- Can also be used to estimate the maximum rather than the maximum at a given location.
- So far have mainly considered voxelwise inference but it would be interesting to extend this to other types of inference but
- Would be cool to develop an RFT method to do this but this is probably quite difficult!
- Worth noting once again that it's important (especially in light of clusterfailure) that existing and emerging statistical methods are tested using this type of big data validation.

Software Availability

- Paper available online.
- Code and scripts to reproduce figures available in SIbootstrap toolbox (github.com/sjdavenport/SIbootstrap). Simulations and thresholding were performed using RFTtoolbox available at github.com/sjdavenport/RFTtoolbox/.
- Slides available on my website.

Bibliography